Search Notes				

Applicati n/Contr l No.	Applicant(s)/Patent und r R xamination
10/650,594	SCHOUTEN ET AL.
Examiner	Art Unit
Long Nauven	2816

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Class	Subclass	Date	Examiner			
327	77,78, 83,142, 143,198, 512,513	01/24/05	LN			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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